

Final Product/Process Change Notification Document #: FPCN22003Z

Document #: FPCN22003Z Issue Date: 8 November 2017

Title of Change:	Lead frame plating supplier change for STK984-190-E	
Proposed Changed Material First Ship Date:	8 November 2018 or earlier upon customer approval	
Current Material Last Order Date:	N/A	
Current Material Last Delivery Date:	N/A	
Product Category:	Active components – Integrated circuits	
Contact information	Contact your local ON Semiconductor Sales Office or Tomohiro.Uda@onsemi.com	
Samples	Contact your local ON Semiconductor Sales Office to place sample order. Sample requests are to be submitted no later than 45 days after publication of this change notification.	
Sample Availability Date:	N/A	
PPAP Availability Date:	18 March 2016	
Additional Reliability Data	Contact your local ON Semiconductor Sales Office or <u>Kazutoshi.Kitazume@onsemi.com</u>	
Type of Notification	This is a Final Product/Process Change Notification (FPCN) sent to customers. FPCNs are issued 12 months prior to implementation of the change or earlier upon customer approval. ON Semiconductor will consider this proposed change and it's conditions acceptable, unless an inquiry is made in writing within 45 days of delivery of this notice. To do so, contact <pcn.support@onsemi.com>.</pcn.support@onsemi.com>	
Change Category	Type of Change	
Process – Assembly	New / change of lead frame plating	

Description and Purpose:

This is a Final Process Change to announce the replacement of existing lead frame plating for STK984-190-E.

The reason is that the existing plating supplier of lead frame will be end of life.

The table below shows comparison of lead frame plating between two materials.

Process	Changing	Contents				Remark	
Process	Point	Machine	Man	Method	Material	Spec	Remark
Raw Material	Yes / No	No	No	No	No	No	No change
Naw Waterial	Point	_	_	_	_		
Plating	Yes / No	Yes	Yes	Yes	Yes	No	Supplier change
Plating	Point	В	В	В	В		Supplier A \rightarrow B
Stamping	Yes / No	No	No	No	No	No	No change
Stamping	Point	_		_	_		

The change point of the lead frame plating specification.

	Item	Before Change	After Change
	Ni Plating	Min1.5um	No change
Diating Coop	Sn Plating	Min3.0um	No change
Plating Spec.	Plating method	Electroplating	No change
	Glossiness	Mat	No change
Supplier		А	В
IPD Package Dimensions		No change	

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Reason / Motivat	tion for Change:		nal Process Change to announce the re reason is that the existing plating sup			
Anticipated impa function, reliabili or manufacturab	ity, product safety	No anticipa	ated impacts.			
Sites Affected:						
☐ All site(s)	not applicable		DN Semiconductor site(s):			
Marking of Parts, Change:	/ Traceability of	Identification	ation via lot code			
Reliability Data S	ummary:					
	-					
QV DEVICE NAME:	STK984-190-E					
RMS:						
Reference (Generic						
STK984-170-E (Rel.	Tracking# J38132)					
PACKAGE: DIP-S3						
Test	Specificati		Condition	Interval	Results	
Test H3TRB	EIAJ ED-4701/	100	Condition Ta=85°C, 85%RH, VDS=40V	Interval 1000hrs	Results 0/11	
НЗТВВ	EIAJ ED-4701/ Test Method 1	100 102	Ta=85°C, 85%RH, VDS=40V	1000hrs	0/11	
	EIAJ ED-4701/	100 102				
НЗТВВ	EIAJ ED-4701/ Test Method 2 EIAJ ED-470 B-123 EIAJ ED-4701/	100 102 1	Ta=85°C, 85%RH, VDS=40V	1000hrs 96hrs	0/11	
H3TRB AC TC	EIAJ ED-4701/ Test Method 2 EIAJ ED-470 B-123 EIAJ ED-4701/ Test Method 2	100 .02 1 100 .05	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa	1000hrs 96hrs 1000cyc	0/11 0/11 0/11	
H3TRB AC	EIAJ ED-4701/ Test Method 2 EIAJ ED-470 B-123 EIAJ ED-4701/	100 .02 1 1 100 .05 200	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa	1000hrs 96hrs	0/11	
H3TRB AC TC	EIAJ ED-4701/ Test Method 2 EIAJ ED-470 B-123 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/	100 102 1 100 105 200 201	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa Ta= -40°C to +150°C Ta = 150°C	1000hrs 96hrs 1000cyc 1000hrs	0/11 0/11 0/11 0/11	
AC TC HTSL	EIAJ ED-4701/ Test Method 2 EIAJ ED-470 B-123 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ Test Method 2	100 102 1 100 105 200 201	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa Ta=-40°C to +150°C	1000hrs 96hrs 1000cyc	0/11 0/11 0/11	
AC TC HTSL	EIAJ ED-4701/ Test Method 2 EIAJ ED-470 B-123 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/	100 102 1 100 105 200 201	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa Ta= -40°C to +150°C Ta = 150°C	1000hrs 96hrs 1000cyc 1000hrs	0/11 0/11 0/11 0/11	
H3TRB AC TC HTSL HTRB	EIAJ ED-4701/ Test Method 2 EIAJ ED-470 B-123 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ Test Method 2	100 102 1 100 105 200 201	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa Ta= -40°C to +150°C Ta = 150°C	1000hrs 96hrs 1000cyc 1000hrs	0/11 0/11 0/11 0/11	
H3TRB AC TC HTSL HTRB	EIAJ ED-4701/ Test Method 2 EIAJ ED-470 B-123 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/	100 102 1 100 105 200 201	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa Ta= -40°C to +150°C Ta = 150°C	1000hrs 96hrs 1000cyc 1000hrs	0/11 0/11 0/11 0/11	
H3TRB AC TC HTSL HTRB	EIAJ ED-4701/ Test Method 2 EIAJ ED-470 B-123 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ Test Method 2	100 102 1 100 105 200 201	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa Ta= -40°C to +150°C Ta = 150°C	1000hrs 96hrs 1000cyc 1000hrs	0/11 0/11 0/11 0/11	
H3TRB AC TC HTSL HTRB Electrical Character	EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ B-123 EIAJ ED-4701/ Test Method 2	100 102 1 100 105 200 201	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa Ta= -40°C to +150°C Ta = 150°C	1000hrs 96hrs 1000cyc 1000hrs	0/11 0/11 0/11 0/11	
H3TRB AC TC HTSL HTRB	EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ B-123 EIAJ ED-4701/ Test Method 2	100 102 1 100 105 200 201	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa Ta= -40°C to +150°C Ta = 150°C	1000hrs 96hrs 1000cyc 1000hrs	0/11 0/11 0/11 0/11	
H3TRB AC TC HTSL HTRB Electrical Character Electrical character	EIAJ ED-4701/ Test Method 2 EIAJ ED-4701/ B-123 EIAJ ED-4701/ Test Method 2	100 102 1 100 105 200 201	Ta=85°C, 85%RH, VDS=40V Ta=121°C,100%RH, 2.05x10 ⁵ Pa Ta= -40°C to +150°C Ta = 150°C	1000hrs 96hrs 1000cyc 1000hrs	0/11 0/11 0/11 0/11	

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